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Haude, M.; Brennecke, R.; Erbel, R.; Renneisen, U.; Lang, M.; Eissner, D.; Ha K.; Meyer, J.;

Computers in Cardiology 1990. Proceedings. , 23-26 Sept. 1990
Pages:141 - 144

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2 Directional low-pass filtering for improved accuracy and reproducibility of stenosis quantification in coronary arteriograms

Ying Sun; Lucariello, R.J.; Chiaramida, S.A.;

Medical Imaging, IEEE Transactions on , Volume: 14 , Issue: 2 , June 1995
Pages:242 - 248

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